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November 2013

# **FQI7N80**

# N-Channel QFET® MOSFET

800 V, 6.6 A, 1.5 Ω

# **Description**

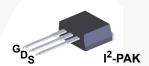
This N-Channel enhancement mode power MOSFET is • 6.6 A, 800 V,  $R_{DS(on)}$  = 1.5  $\Omega$  (Max.) @  $V_{GS}$  = 10 V, produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state

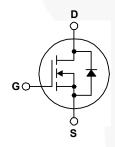
• Low Gate Charge (Typ. 40 nC) resistance, and to provide superior switching performance • Low Crss (Typ. 19 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power • 100% Avalanche Tested factor correction (PFC), and electronic lamp ballasts.

## **Features**

- $I_D = 3.7 A$

- RoHS Compliant





# Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter	FQI7N80TU	Unit	
V <sub>DSS</sub>	Drain-Source Voltage	800	V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)	6.6	Α	
	- Continuous (T <sub>C</sub> = 100°C)	4.2	Α	
I <sub>DM</sub>	Drain Current - Pulsed (Note 1)	26.4	А	
V <sub>GSS</sub>	Gate-Source Voltage	± 30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	580	mJ	
I <sub>AR</sub>	Avalanche Current (Note 1)	6.6	A	
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	16.7	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.0	V/ns	
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *	3.13	W	
	Power Dissipation (T <sub>C</sub> = 25°C)	167	W	
	- Derate above 25°C	1.34	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering, 1/8"	300	°C	
'L	from Case for 5 Seconds.	300	C	

# **Thermal Characteristics**

Symbol	Parameter	FQI7N80TU	Unit
$R_{\thetaJC}$	Thermal Resistance, Junction to Case, Max.	0.75	
В	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (*1 in <sup>2</sup> Pad of 2-oz Copper), Max.	40	

# **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQI7N80TU	FQI7N80	I <sup>2</sup> -PAK	Tube	N/A	N/A	50 units

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu \text{ A}$	800			V
ΔBV <sub>DSS</sub> / ΔT	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.77		V/°C
I <sub>DSS</sub>	Zoro Coto Voltago Droin Current	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V			10	μΑ
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 640 V, T <sub>C</sub> = 125°C			100	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.3 A		1.2	1.5	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 3.3 A		5		S
<b>Dynam</b> C <sub>iss</sub>	ic Characteristics Input Capacitance			1420	1850	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		150	195	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1.0 MHz		19	25	рF
	·			10	20	ρı
	ing Characteristics		1			1
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 6.6 A,		35	80	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$		80	170	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	(Note 4)		95	200	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)		55	120	ns
Qg	Total Gate Charge	$V_{DS} = 640 \text{ V}, I_{D} = 6.6 \text{ A},$		40	52	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		8.5		nC
Q <sub>gd</sub>	Gate-Drain Charge	Note 4)	/	20		nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings				
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				6.6	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				26.4	Α
		n-Source Diode Forward Voltage V <sub>GS</sub> = 0 V, I <sub>S</sub> = 6.6 A				

# $\mathbf{Q}_{\mathrm{rr}}$

 $t_{rr}$ 

- 1. Repetitive rating : pulse-width limited by maximum junction temperature. 2. L = 25 mH, I<sub>AS</sub> = 6.6 A, V<sub>DD</sub> = 50 V, R<sub>G</sub> = 25  $\Omega$ , starting T<sub>J</sub> = 25°C.

Reverse Recovery Time

Reverse Recovery Charge

- 3. I  $_{SD} \leq$  6.6 A, di/dt  $\leq$  200 A/µs  $\,$  , V  $_{DD} \leq$  BV  $_{DSS_i}$  starting  $\,$  T  $_{J}$  = 25°C.
- 4. Essentially independent of operating temperature.

ns

μС

400

4.3

 $V_{GS} = 0 V, I_{S} = 6.6 A,$ 

 $dI_F / dt = 100 A/\mu s$ 

# **Typical Characteristics**

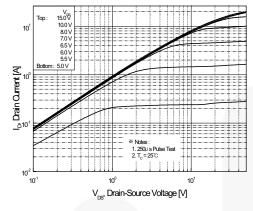


Figure 1. On-Region Characteristics

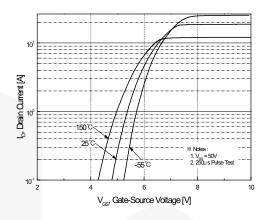


Figure 2. Transfer Characteristics

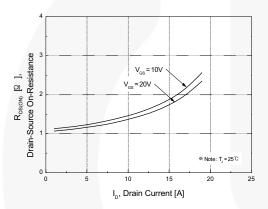


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

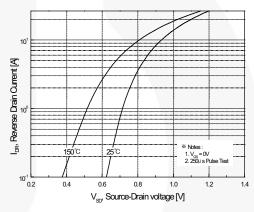


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

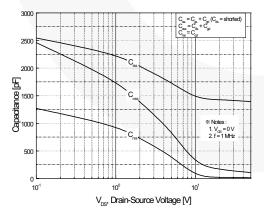


Figure 5. Capacitance Characteristics

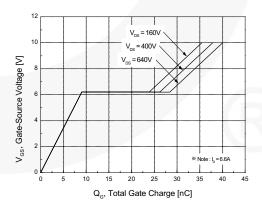


Figure 6. Gate Charge Characteristics

# Dain Source Beakdown Vottege Note: Note:

-100

-50

Typical Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

T, Junction Temperature [°C]

150

200

100

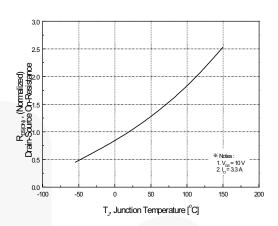


Figure 8. On-Resistance Variation vs. Temperature

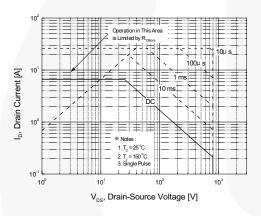


Figure 9. Maximum Safe Operating Area

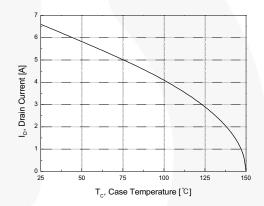


Figure 10. Maximum Drain Current vs. Case Temperature

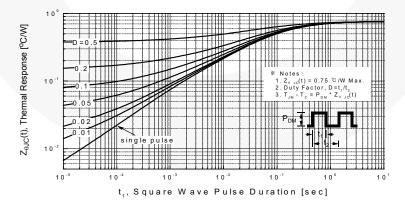


Figure 11. Transient Thermal Response Curve

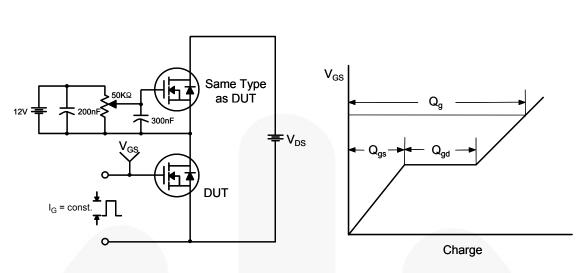


Figure 12. Gate Charge Test Circuit & Waveform

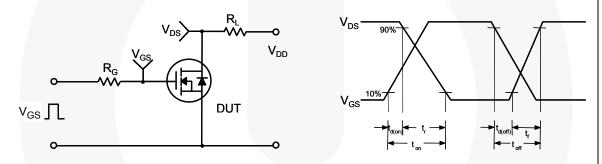


Figure 13. Resistive Switching Test Circuit & Waveforms

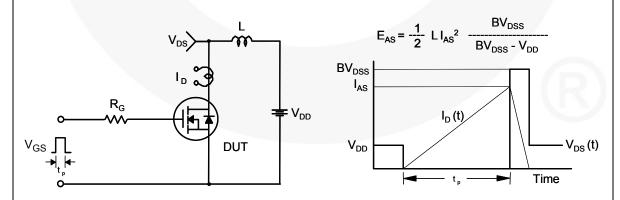
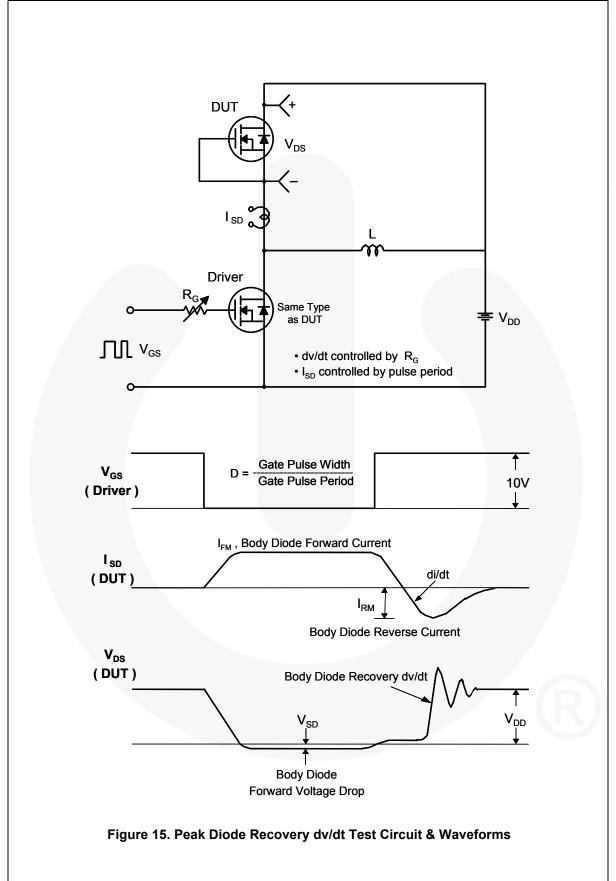


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



## **Mechanical Dimensions**

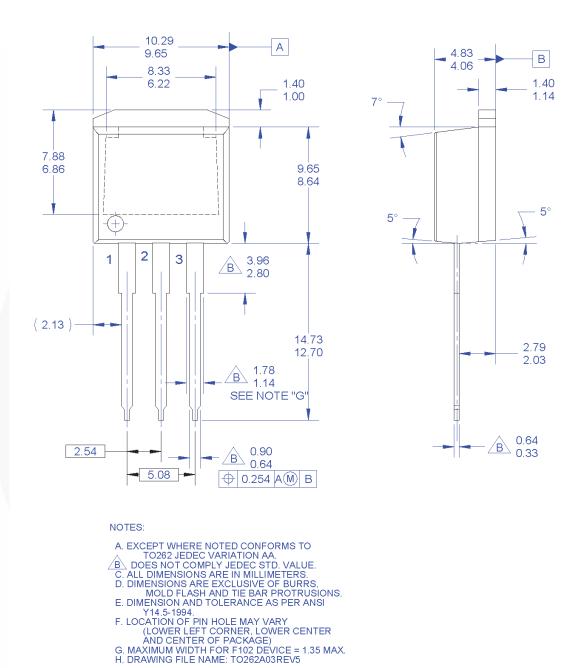


Figure 16. TO262 (I<sup>2</sup>PAK), Molded, 3-Lead, Jedec Variation AA

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